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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

Sheet 1 of 1
ATTORNEY DOCKET NO. APPLICATION NO.

0862.1463 09/890,143

FIRST NAMED INVENTOR

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Masaki YAMAMOTO
FILING DATE GROUPART UNIT
July 26, 2001 2882

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	5,935,737	8/10/1999	Yan			
	AB	5,085,957	2/4/1992	Hosono			
	AC					<u></u>	
	AD						· · · · · · · · · · · · · · · · · · ·
	AE					1, 100,	
	AF		,				

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
	AG	EP 0 279 670	8/24/1988	Europe		
	АН	4-204603	7/27/1992	Japan		Х
	Al	6-180399	6/28/1994	Japan		Х
	AJ	11-23796	1/29/1999	Japan		Х
	AK	63-211130	9/2/1988	Japan		Х
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)				ATION NO
	АМ	Hawryluk et al., "Repair of Opaque Defects on Reflection Masks for Soft X-Ray Projection Lithography", J. Vac. Sci. Technol. B 10(6), Nov/Dec. 1992, pgs. 3182-3185.		

EXAMINER	DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.